2SC5027

NPN SILICON TRANSISTOR

HIGH VOLTAGE AND HIGH RELIABILITY

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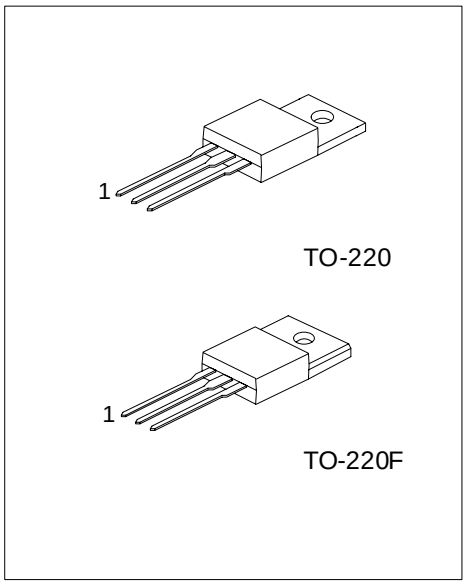


*Pb-free plating product number: 2SC5027L

■ FEATURES

* High Voltage (V_{CEO} = 800V)
* High Speed Switching
* Wide SOA

■ ORDERING INFORMATION

Order Number		Package	Pin Assignment			Packing
Normal	Lead Free Plating		1	2	3	
2SC5027-x-TA3-T	2SC5027L-x-TA3-T	TO-220	B	C	E	Tube
2SC5027-x-TF3-T	2SC5027L-x-TF3-T	TO-220F	B	C	E	Tube

2SC5027L-x-TA3-T

(1)Packing Type	(1) T: Tube
(2)Package Type	(2) TA3: TO-220, TF3: TO-220F
(3)Rank	(3) x: refer to Classification of h_{FE1}
(4)Lead Plating	(4) L: Lead Free Plating, Blank: Pb/Sn

■ ABSOLUTE MAXIMUM RATINGS (Tc = 25℃)

PARAMETER	SYMBOL	RATINGS	UNIT
Collector-Base Voltage	V_{CBO}	850	V
Collector-Emitter Voltage	V_{CEO}	800	V
Collector-Emitter Voltage	V_{EBO}	7	V
Peak Collector Current	I_C	3	A
Collector Current (Pulse)	I_{CP}	10	A
Base Current	I_B	1.5	A
Power Dissipation	P_C	50	W
Junction Temperature	T_J	150	℃
Storage Temperature	T_{STG}	-55 ~ +150	℃

Note Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ ELECTRICAL CHARACTERISTICS (T_C= 25℃, unless otherwise specified.)

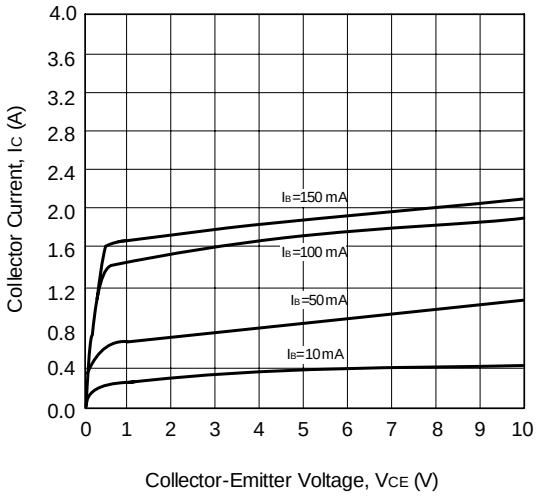
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Collector-Base Breakdown Voltage	BV_{CBO}	I_C=1mA, I_E=0	850			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	I_C=5mA, I_B=0	800			V
Emitter-Base Breakdown Voltage	BV_{EBO}	I_E=1mA, I_C=0	7			V
Collector-Emitter sustaining Voltage	$V_{CEX(SUS)}$	I_C=1.5A, I_{B1}= -I_{B2}=0.3A L=2mH, Clamped	800			V
Collector Cut-off Current	I_{CBO}	V_{CB}=800V, I_E=0			10	μA
Emitter Cut-off Current	I_{EBO}	V_{EB}=5V, I_C=0			10	μA
DC Current Gain	h_{FE1}	V_{CE}=5V, I_C=0.2A	10		40	
	h_{FE2}	V_{CE}=5V, I_C=1A	8			
Collector-Emitter Saturation Voltage	$V_{CE (SAT)}$	I_C=1.5A, I_B=0.3A			2	V
Base-Emitter Saturation Voltage	$V_{BE (SAT)}$	I_C=1.5A, I_B=0.3A			1.5	V
Output Capacitance	Cob	V_{CB}=10V, f=1MHz, I_E=0		60		pF
Current Gain Bandwidth Product	f_T	V_{CE}=10V, I_C=0.2A		15		MHz
Turn ON Time	t_{ON}	V_{CC}=400V I_C=5I_{B1}= -2.5I_{B2}=2A R_L=200Ω			0.5	μs
Storage Time	t_S				3	μs
Fall Time	t_F				0.3	μs

■ CLASSIFICATION of h_{FE1}

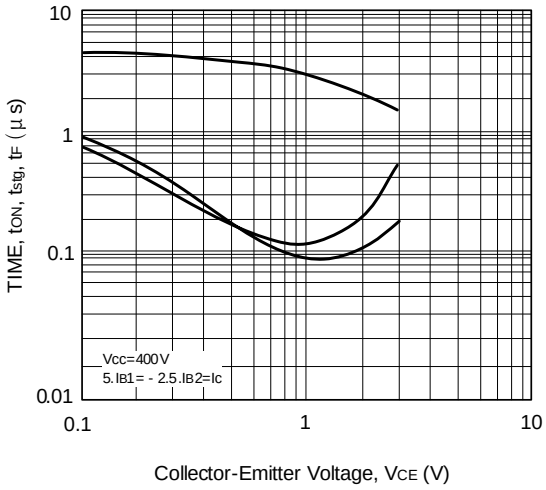
RANK	N	R	O
RANGE	10 ~ 20	15 ~ 30	20 ~ 40

■ TYPICAL CHARACTERISTICS

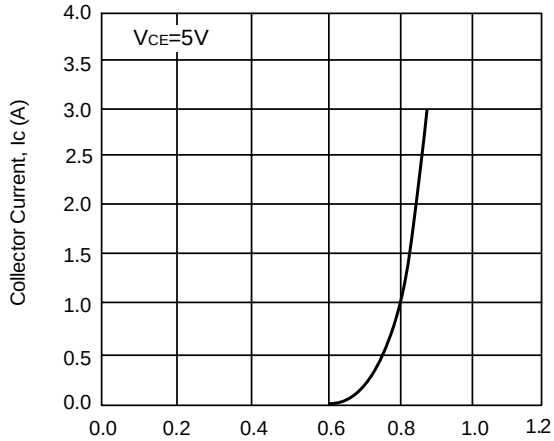
Static Characteristic
Collector Current vs. Collector-Emitter Voltage



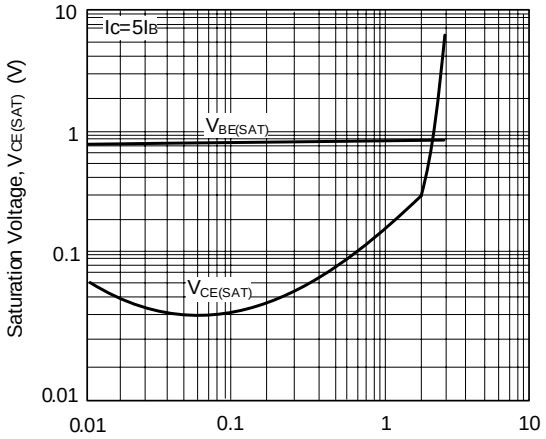
Switching Time
Time vs. Collector-Emitter Voltage



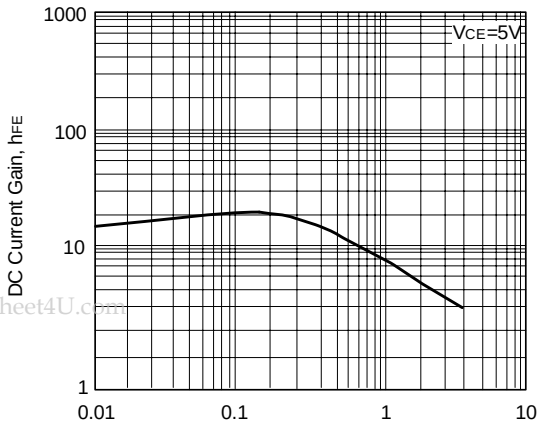
Collector Current vs. Base-Emitter Voltage



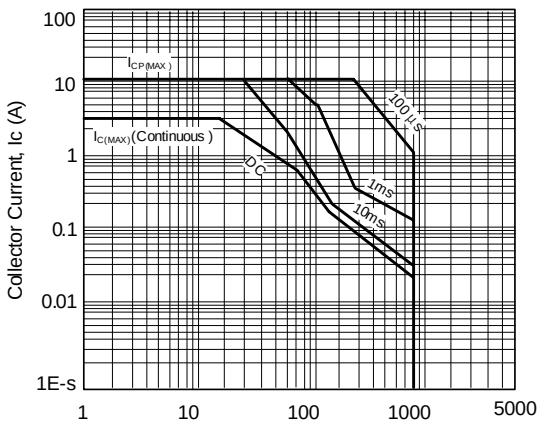
Saturation Voltage vs. Collector Current



DC Current Gain vs. Collector Current

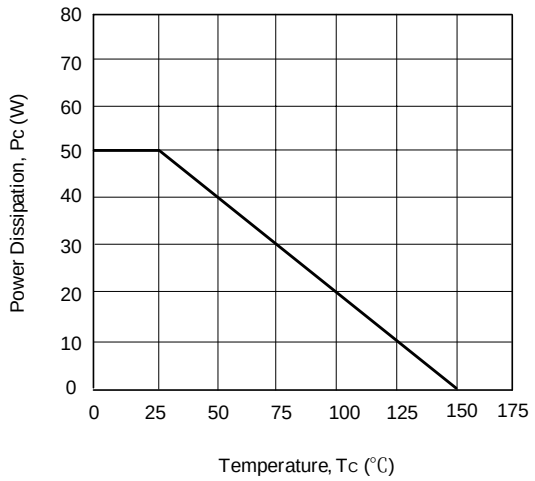


Safe Operating Area
Collector Current vs. Collector-Emitter Voltage



■ TYPICAL CHARACTERISTICS(Cont.)

Power vs. Temperature Derating Curve



Reverse Bias Operating Area
Collector Current vs. Collector-Emitter Voltage